



<p align="center">Searched</p> 	<p>Application/Control No.</p> <p>10507113</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>BRUNSON ET AL.</p>
	<p>Examiner</p> <p>Chang, Joseph</p>	<p>Art Unit</p> <p>2817</p>

Class	SubClass	Date	Examiner
331	155, 154, 116R, 116M	6/16/06	JC


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Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
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	Examiner Chang, Joseph	Art Unit 2817

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